

# Standard Practice for X-Ray Determination of Retained Austenite in Steel with Near Random Crystallographic Orientation<sup>1</sup>

This standard is issued under the fixed designation E 975; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon ( $\epsilon$ ) indicates an editorial change since the last revision or reapproval.

#### INTRODUCTION

The volume percent of retained austenite (face-centered cubic phase) in steel is determined by comparing the integrated chromium or molybdenum X-ray diffraction intensity of ferrite (bodycentered cubic phase) and austenite phases with theoretical intensities. This method should be applied to steels with near random crystallographic orientations of ferrite and austenite phases because preferred crystallographic orientations can drastically change these measured intensities from theoretical values. Chromium radiation was chosen to obtain the best resolution of X-ray diffraction peaks for other crystalline phases in steel such as carbides. No distinction has been made between ferrite and martensite phases because the theoretical X-ray diffraction intensities are nearly the same. Hereafter, the term ferrite can also apply to martensite. This practice has been designed for unmodified commercial X-ray diffractometers or diffraction lines on film read with a densitometer.

Other types of X-radiations such as cobalt or copper can be used, but most laboratories examining ferrous materials use chromium radiation for improved X-ray diffraction peak resolution or molybdenum radiation to produce numerous X-ray diffraction peaks. Because of special problems associated with the use of cobalt or copper radiation, these radiations are not considered in this practice.

### 1. Scope

1.1 This practice covers the determination of retained austenite phase in steel using integrated intensities (area under peak above background) of X-ray diffraction peaks using chromium  $K_{\alpha}$  or molybdenum  $K_{\alpha}$  X-radiation.

1.2 The method applies to carbon and alloy steels with near random crystallographic orientations of both ferrite and austenite phases.

1.3 This practice is valid for retained austenite contents from 1 % by volume and above.

1.4 If possible, X-ray diffraction peak interference from other crystalline phases such as carbides should be eliminated from the ferrite and austenite peak intensities.

1.5 Substantial alloy contents in steel cause some change in peak intensities which have not been considered in this method. Application of this method to steels with total alloy contents exceeding 15 weight % should be done with care. If necessary, the users can calculate the theoretical correction factors to account for changes in volume of the unit cells for

austenite and ferrite resulting from variations in chemical composition.

1.6 This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.

### 2. Significance and Use

2.1 Significance—Retained austenite with a near random crystallographic orientation is found in the microstructure of heat-treated low-alloy, high-strength steels that have medium (0.40 weight %) or higher carbon contents. Although the presence of retained austenite may not be evident in the microstructure, and may not affect the bulk mechanical properties such as hardness of the steel, the transformation of retained austenite to martensite during service can affect the performance of the steel.

2.2 Use—The measurement of retained austenite can be included in low-alloy steel development programs to determine its effect on mechanical properties. Retained austenite can be measured on a companion sample or test section that is included in a heat-treated lot of steel as part of a quality control practice. The measurement of retained austenite in steels from service can be included in studies of material performance.

<sup>&</sup>lt;sup>1</sup> This practice is under the jurisdiction of ASTM Committee E04 on Metallography and is the direct responsibility of Subcommittee E04.11 on X-Ray and Electron Metallography.

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	TABLE 1 Calculated Theoretical Intensities Using Chromium $K_{\alpha}$ Radiation										
hkl	Sinθ/λ	θ	f	$\Delta f'$	$\Delta f''$	/F/ <sup>2</sup>	LP	Р	T <sup>B</sup>	N <sup>2</sup>	R
( $\alpha$ iron, bod	( $\alpha$ iron, body-centered cubic, unit-cell dimension $a_{\alpha}$ = 2.8664Å):										
110	0.24669	34.41	18.474	-1.6	0.9	1142.2	4.290	12	0.9577	0.001803 <sup><i>B</i></sup>	101.5 <sup>C</sup>
200	0.34887	53.06	15.218	-1.6	0.9	745.0	2.805	6	0.9172	0.001803 <sup><i>B</i></sup>	20.73 <sup>C</sup>
211	0.42728	78.20	13.133	-1.6	0.8	534.6	9.388	24	0.8784	0.001803 <sup>B</sup>	190.8 <sup><i>C</i></sup>
(γ iron, face	e-centered cubic,	, unit-cell dirr	nension $a_o = 3.1$	60Å):							
111	0.24056	33.44	18.687	-1.6	0.9	4684.4	4.554	8	0.9597	0.0004594 <sup><i>B</i></sup>	75.24 <sup><i>C</i></sup>
200	0.27778	39.52	17.422	-1.6	0.9	4018.3	3.317	6	0.9467	0.0004594 <sup><i>B</i></sup>	34.78 <sup>C</sup>
220	0.39284	64.15	14.004	-1.6	0.8	2472.0	3.920	12	0.8962	0.0004594 <sup><i>B</i></sup>	47.88 <sup>C</sup>

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<sup>A</sup> Data from "International Tables for X-Ray Crystallography," Physical and Chemical Tables, Vol III, Kynoch Press, Birmingham, England, 1962, pp. 60, 61, 210, 213; Weighted  $K_{\alpha 1}$  and  $K_{\alpha 2}$  value used ( $\lambda = 2.29092 \text{\AA}$ ).

Temperature factor ( $T = e^{-2M}$ ) where  $M = B (\sin^2 \theta)/\lambda^2$  and 2B = 0.71. Also N is the reciprocal of the unit-cell volume.

<sup>C</sup> Calculated intensity includes the variables listed that change with X-ray diffraction peak position.

## 3. Principles for Retained Austenite Measurement by **X-Ray Diffraction**

3.1 A detailed description of a retained austenite measurement using X-ray diffraction is presented by the Society ofAutomotive Engineers.<sup>2</sup> Since steel contains crystalline phases such as ferrite or martensite and austenite, a unique X-ray diffraction pattern for each crystalline phase is produced when the steel sample is irradiated with X-irradiation. Carbide phases in the steel will also produce X-ray diffraction patterns.

3.2 For a randomly oriented sample, quantitative measurements of the relative volume fraction of ferrite and austenite can be made from X-ray diffraction patterns because the total integrated intensity of all diffraction peaks for each phase is proportional to the volume fraction of that phase. If the crystalline phase or grains of each phase are randomly oriented, the integrated intensity from any single diffraction peak ( hkl) crystalline plane is also proportional to the volume fraction of that phase:

where:

$$I_{\alpha}^{\ hkl} = KR_{\alpha}^{\ hkl} V_{\alpha}/2\mu$$

 $K = (I_o^{e^4} / m^2 c^4) \times (\lambda^3_A / 32\pi r)$ 

and

$$R_{\alpha}^{\ hkl} = \frac{1(/F/^2 p L P e^{-2M})}{v^2}$$

where:

$I_{\alpha}^{hkl}$	=	integrated intensity per angular diffraction peak
		$(hkl)$ in the $\alpha$ -phase,
$I_o$	=	intensity of the incident beam,
μ	=	linear absorption coefficient for the steel,
e,m	=	charge and mass of the electron,
r	=	radius of the diffractometer,
с	=	velocity of light,
λ	=	wavelength of incident radiation,
Α	=	cross sectional area of the incident beam,
v	=	volume of the unit cell,
$/F/^{2}$	=	structure factor times its complex conjugate,
р	=	multiplicity factor of the ( <i>hkl</i> ) reflection,
θ	=	Bragg angle,

<sup>&</sup>lt;sup>2</sup> Retained Austenite and Its Measurement by X-ray Diffraction, SAE Special Publication 453, SAE, Warrendale, PA 15096.

- LP = Lorentz Polarization factor which is equal to  $(1 + \cos^2 2\theta)/\sin^2 \theta \cos \theta$  for normal diffractometric analysis but becomes  $(1 + \cos\theta^2 2\alpha \cos^2)$  $2\theta$ /(sin<sup>2</sup>  $\theta$  cos  $\theta$ ) (1 + cos<sup>2</sup> 2 $\alpha$ ) when a monochromator is used in which diffraction by monochromator and sample take place in the same plane;  $2\alpha$  is the diffraction angle of the monochromator crystal. If diffraction by the monochromator occurs in a plane perpendicular to the plane of sample diffraction, then  $LP = (\cos^2)$  $2\alpha + \cos^2 2\theta$ /sin<sup>2</sup>  $\theta$ cos (1 + cos<sup>2</sup>  $2\alpha$ ),
  - = Debye-Waller or temperature factor which is a function of  $\theta$  where  $M = B(\sin^2 \theta)/\lambda^2$ ,  $B = 8\pi^2$  $(\mu_s)^2$ , where  $\mu_s^2$  is the mean square displacement of the atoms from their mean position, in a direction perpendicular to the diffracting plane, and

= volume fraction of the  $\alpha$  -plane.  $V_{\alpha}$ 

K is a constant which is dependent upon the selection of instrumentation geometry and radiation but independent of the nature of the sample. The parameter, R, is proportional to the theoretical integrated intensity. The parameter, R, depends upon interplanar spacing (*hkl*), the Bragg angle,  $\theta$ , crystal structure, and composition of the phase being measured. R can be calculated from basic principles.

3.3 For steel containing only ferrite ( $\alpha$ ) and austenite ( $\gamma$ ) and no carbides, the integrated intensity from the (*hkl*) planes of the ferrite phase is expressed as:

$$I_{\alpha}^{\ hkl} = KR_{\alpha}^{\ hkl} V_{\alpha}/2\mu$$

3.3.1 A similar equation applies to austenite. We can then write for any pair of austenite and ferrite hkl peaks:

$$I_{\alpha}^{\ hkl}/I_{\gamma}^{\ hkl} = \left[ (R_{\alpha}^{\ hkl}/R_{\gamma}^{\ hkl})(V_{\alpha}/V_{\gamma}) \right]$$

3.3.2 The above ratio holds if ferrite or martensite and austenite are the only two phases present in a steel and both phases are randomly oriented. Then:

$$V_{\alpha} + V_{\gamma} = 1$$

3.3.3 The volume fraction of austenite ( $V_{\gamma}$ ) for the ratio of measured integrated intensities of ferrite and austenite peak to *R*-value is:

$$V_{\gamma} = \left[I_{\gamma}/R_{\gamma}/(I_{\alpha}/R_{\alpha}) + (I_{\gamma}/R_{\gamma})\right] \tag{1}$$

3.3.4 For numerous ferrite and austenite peaks each ratio of measured integrated intensity to *R*-value can be summed:

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$$V_{\gamma} = \left[ \left( \frac{1}{q} \sum_{j=1}^{q} \frac{I \gamma j}{R \gamma j} \right) / \left( \frac{1}{P} \sum_{i=1}^{P} I \alpha i / R \alpha i \right) + \left( \frac{1}{q} \sum_{j=1}^{q} I \gamma j / R \gamma j \right) \right]$$
(2)

3.3.5 If carbides are present:

 $V_{\alpha}$ 

$$+V_{\gamma}+V_{c}=1$$

3.3.6 Then the volume fraction of austenite (  $V_{\alpha}$ ) for the ratio of measured ferrite and austenite integrated intensity to *R*-value is:

$$V_{\gamma} = [(1 - V_c)(I_{\gamma}/R_{\gamma})/(I_{\alpha}/R_{\alpha}) + (I_{\gamma}/R_{\gamma})]$$
(3)

3.3.7 For numerous ferrite and austenite peaks the ratio of measured integrated intensity to *R*-values can be summed:

$$V_{\gamma} = \left[ (1 - V_c) (1/q \sum_{j=1}^{q} (I_{\gamma j} / R_{\gamma j} j)) / 1 / P \sum_{i=1}^{p} (I_a i / R_a i) + 1/q \sum_{i=1}^{q} (I_{\gamma j} / R_{\gamma j} j) \right]$$
(4)

3.4 The volume fraction of carbide,  $V_c$ , should be determined by chemical extraction or metallographic methods. Adequate X-ray diffraction peak resolution for the identification of carbide peaks is required to avoid including carbide peaks in the retained austenite measurement.

#### 4. Procedure

# 4.1 Sample Preparation:

4.1.1 Samples for the X-ray diffractometer must be cut with a minimum amount of heat effect. Since most steels containing retained austenite are relatively hard, abrasive cutoff wheels are frequently used. If adequate cooling is not used, heat effects from abrasive cutoff wheels can be substantial and, in some cases, can transform retained austenite. Saw cutting rather than abrasive wheel cutting is recommended for sample removal whenever it is practical.

4.1.2 Rough grinding using a milling tool or high-pressure coarse grinding can deform the surface and transform some of the retained austenite to a depth that is greater than the surface depth analyzed. Final milling or rough grinding cuts limited to a depth of 0.010-in. or less should reduce the depth of deformation.

4.1.3 Standard metallographic wet-grinding and polishing methods shall be used to prepare samples for X-ray analysis. Grit reductions of 80, 120, 240, 320, 400, and 600 silicon carbide or alumina abrasives may be used but other valid grit combinations may also be used. A final surface polish of 6-µm diamond or an equivalent abrasive polish is required. Sample etching, observation for heat effects, and repolishing is a recommended safeguard.

4.1.4 Since deformation caused by dull papers or overpolishing can transform some of the retained austenite, electrolytic polishing or chemical polishing of initial samples of each grade and condition should be used to verify proper metallographic sample preparation. Standard chromic-acetic acid for electropolishing 0.005-in. from samples ground to 600 grit or specific chemical polishing solutions for a particular grade of steel polished to a 6-µm finish can be used to verify the metallographic polish. Hot-acid etching is not recommended because of selective etching of one phase or along a preferred crystallographic direction.

4.1.5 Sample size must be large enough to contain the Xray

beam at all angles of  $2\theta$  required for the X-ray diffraction analysis to prevent errors in the analysis. In most cases, a 1- in. square area is sufficient, but sample size depends upon the dimensions of the incident X-ray diffraction. When using molybdenum radiation, select peaks in the range from 28 to 40°  $2\theta$  for best results.

# 4.2 X-Ray Equipment:

4.2.1 A standard X-ray diffractometer with a pulse height selector circuit is preferred for the measurement, but an X-ray camera plus densitometer readings of the film may be used. X-ray film and adequate photographic development techniques are required to assure a linear response of the film to the X-ray intensity.

4.2.2 A chromium X-ray source with a vanadium metal or compound filter to reduce the  $K_{\beta}$  radiation is recommended. Chromium radiation produces a minimum of Xray fluorescence of iron. Chromium radiation provides for the needed X-ray diffraction peak resolution and allows for the separation of carbide peaks from austenite and ferrite peaks.

4.2.3 Other radiation such as copper, cobalt, or molybdenum can be used, but none of these provide the resolution of chromium radiation. Copper radiation is practical only when a diffracted-beam monochromator is employed, because iron X-ray fluorescence will obscure the diffracted peaks.

4.2.4 A molybdenum source with a zirconium filter is used to produce a large number of X-ray diffraction peaks.

4.3 *X-Ray Method*—X-ray diffraction peaks from other crystalline phases such as carbides must be separated from austenite and ferrite peaks. The linearity of the chart recorder or photographic film shall be verified prior to utilizing this method.

4.3.1 Entire diffraction peaks minus background under the peaks shall be recorded to obtain integrated peak intensities. Peaks without carbide or second phase interference can be scanned, and the total peak plus background recorded. Background counts are obtained by counting on each side of the peak for one-half of the total peak counting time. Total background is subtracted from peak plus background to obtain the integrated intensity. Alternatively, software supplied with the diffractometer can be used. In general, a diffractometer scanning rate of  $0.5^{\circ}2\theta/min$  or less is recommended to define the peaks for austenite contents of less than 5 %.

4.3.2 Where carbide or other phase X-ray diffraction peak interference exists, planimeter measurements of area under the austenite and ferrite peaks on X-ray diffraction charts can be used to obtain integrated intensity. Alternatively, software supplied with the diffractometer can be used. Carbide interference with austenite and ferrite peaks of the more common carbides is shown in Fig. 1.

4.3.3 Another method of determining integrated intensity involves cutting peak areas from the charts and weighing them with an analytical balance.

4.3.4 Assuming a 10 % variation in each peak intensity, chromium peak ratios of integrated intensities (areas under the peaks minus background) for the (220) austenite peak relative to (200) austenite peak shall range from 1.1 to 1.7 to satisfy the requirement of this practice for a near-random orientation of

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Note 1—"M" represents more than one type of metal. FIG. 1 Example of Carbide Interference

austenite. Equivalent molybdenum peak ratios range from 0.7 to 0.5.

4.3.5 Assuming a 10 % variation in each peak intensity, chromium peak ratios of integrated intensities for the (211) ferrite peak relative to the (200) ferrite peak range from 8 to 11 to satisfy the requirement of this practice for a near-random orientation of ferrite. Equivalent molybdenum peak ratios range from 1.5 to 2.2.

4.3.6 When either the austenite peak ratio or the ferrite peak ratio is above or below the specified range, this method cannot be used.

4.3.7 Three austenite peaks (111), (200), and (220) and three ferrite peaks (110), (200), and (211) can be obtained with chromium radiation on most X-ray diffractometers. Chromium X-ray diffraction limitations may prevent obtaining the entire peak profile for the (211) peak. In this case, the half-peak profile can be doubled with some error in background. A densitometer reading of film from a Debye Scherrer camera may also be used. In many cases, the (111) austenite and (110) ferrite peaks interfere with each other and cannot be resolved. Four peak ratios of the resolved ferrite to austenite peaks are adequate to determine the retained austenite content of near randomly oriented samples.

4.3.8 Calculated theoretical intensities, *R*, for ferrite and austenite peaks are listed in Table 1 using chromium  $K_{\alpha}$ 

radiation and in Table 2 using molybdenum  $K_{\alpha}$  radiation.

4.3.9 The retained austenite content can be estimated from a number of ferrite and austenite intensity to R-value ratios using Eq 2 assuming no carbides are present.

4.3.10 If the volume fraction of carbide has been determined, the volume fraction of austenite can be determined from Eq 3 for a single set of peaks or from Eq 4 for more than one set of peaks using the theoretical intensities listed in Table 1 for chromium radiation or in Table 2 for molybdenum radiation.

## 5. Example

5.1 Using chromium radiation, the integrated intensity (area of peak above background) for ferrite peaks (200) and (211) and for retained austenite peaks (200) and (220) were determined. Values of R for each peak were obtained from Table 1.

5.1.1 The measured integrated intensities and values of R are illustrated in Table 3.

5.1.2 From Eq 1 for the  $\alpha$  (200) and  $\gamma$  (200) peaks:

$$V_{\gamma} = \frac{\frac{1.00}{34.78}}{\frac{1.00}{20.73} + \frac{1.00}{34.78}} = 0.373 \text{ or } 37.3 \text{ \% retained austenite}$$
(5)

5.1.3 From Eq 2 for all four peaks:

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$$V_{\gamma} = \frac{\frac{1}{2}(0.02875 + 0.02945)}{\frac{1}{2}(0.04824 + 0.04979) + \frac{1}{2}(0.02875 + 0.02945)} = 0.373$$
(6)

## 6. Precision and Bias

6.1 *Precision*—On the basis of an interlaboratory test program this method produces an intralaboratory repeatability of 3 % and an interlaboratory reproducibility of 4 % both at the 95 % confidence level.<sup>3</sup> These estimates were derived from measurements of specimens containing about 2.5 %, 5 %, and 15 % by volume austenite in a medium carbon steel. These measures of precision will be degraded with increasing alloy content and also near the minimum detectability limit of 2 %.

6.2 *Bias*—No bias estimate is available because there is no independent test method to determine an accepted reference value from retained austenite. Use of this practice produces comparable values from one facility to another while utilizing a variety of X-ray diffraction instruments.

## 7. Keywords

7.1 austenite; crystallographic orientation; ferrite; martensite; retained austenite; X-ray diffraction

<sup>3</sup> Hinton, R. W., "Interlaboratory Evaluation of ASTM Practice for X-ray Determination of Retained Austenite in Steel with Near-random Crystallographic Orientation" (Practice E 975), *Journal of Testing and Evaluation*, Vol 15, No. 2 March 1987, pp. 95–100.

TABLE 2	Calculated	Theoretical	Intensities	Using	Molybdenum	κ	<b>Radiation</b> <sup>A</sup>
						a	

(n. ion. body-centered cubic, unit-cell dimension a, = 2.8664Å):      10    0.24669    10.10    18.44    0.4    0.9    978.9    29.71    6    0.9172    0.001803    288.0      200    0.34887    14.36    15.218    0.4    0.9    978.9    29.71    6    0.9172    0.001803    288.0      220    0.44338    20.53    11.652    0.3    0.9    47.4    10.47    24    0.8057    0.001803    172.8      221    0.60426    25.43    9.685    0.3    0.9    402.0    8.396    8    0.7716    0.001803    155.6      400    0.69774    2.97.3    8.440    0.3    0.9    28.14    5.999    12    0.6778    0.001803    22.112      411	hkl	Sinθ/λ	θ	f	$\Delta f'$	$\Delta f''$	/F/²	LP	Р	T <sup>B</sup>	N <sup>2B</sup>	R <sup>c</sup>
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	(α iron, bo	ody-centered cub	oic, unit-cell dir	mension $a_o = 2.6$	8664Å):							
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	110	0.24669	10.10	18.474	0.4	1.0	1428.9	62.15	12	0.9577	0.001803	1840
211  0.42728  17.68  13.133  0.4  0.9  735.8  18.95  24  0.874  0.001803  530.0    310  0.55161  23.08  10.542  0.3  0.9  473.4  10.47  24  0.807  0.001803  172.8    322  0.66268  27.64  9.012  0.3  0.9  350.1  6.949  48  0.7390  0.001803  37.56    321  0.66268  27.64  9.012  0.3  0.9  282.4  5.099  12  0.6778  0.001803  32.6    330  0.74006  31.73  8.064  0.3  0.9  282.4  5.099  12  0.6778  0.001803  32.6    322  0.81817  35.55  7.473  0.3  0.9  228.9  3.647  24  0.564  0.001803  28.9    310  0.8545  37.40  7.471  0.3  0.9  127.7  3.360  48  0.570  0.001803  3.610    510  0.95542  42.77  6.719  0.3  0.9  192.2  2.	200	0.34887	14.36	15.218	0.4	0.9	978.9	29.71	6	0.9172	0.001803	288.6
220    0.49338    20.53    11.652    0.3    0.9    57.46    13.62    12    0.8413    0.001803    172.8      222    0.60426    25.43    9.685    0.3    0.9    402.0    8.396    8    0.7716    0.001803    172.6      221    0.66268    27.44    9.012    0.3    0.9    350.1    6.949    46    0.7390    0.001803    14.06      330    0.74006    31.73    8.054    0.3    0.9    282.4    5.089    12    0.6778    0.001803    22.1      410    0.76010    3.67    7.713    0.3    0.9    224.7    4.017    24    0.6217    0.001803    22.63      422    0.8455    37.40    7.211    0.3    0.9    220.3    2.872    0.001803    26.17      521    0.95542    42.77    6.719    0.3    0.9    186.7    2.853    12    0.5009    0.001803    16.07      531    .0712	211	0.42728	17.68	13.133	0.4	0.9	735.8	18.95	24	0.8784	0.001803	530.0
310  0.55161  23.08  10.542  0.3  0.9  473.4  10.47  24  0.8057  0.001803  375.6    321  0.65268  27.64  9.012  0.3  0.9  350.1  6.94  48  0.7390  0.001803  155.6    321  0.65268  27.64  9.012  0.3  0.9  350.1  6.94  48  0.7390  0.001803  14.06    330  0.74006  31.73  8.054  0.3  0.9  282.4  5.09  12  0.6778  0.001803  32.00    3422  0.78010  33.67  7.713  0.3  0.9  282.1  4.017  2.4  0.6492  0.001803  32.80    322  0.81817  3.55  7.437  0.3  0.9  28.9  3.647  24  0.6492  0.001803  35.61    510  0.95542  42.77  6.719  0.3  0.9  28.9  3.647  24  0.01803  5.67    521  0.96542  42.77  6.719  0.3  0.9  183.2  2.735  24	220	0.49338	20.53	11.652	0.3	0.9	574.6	13.62	12	0.8413	0.001803	142.5
222    0.60426    25.43    9.685    0.3    0.9    402.0    8.396    8    0.7716    0.001803    37.56      321    0.68268    27.64    9.012    0.3    0.9    316.1    5.892    6    0.7708    0.001803    14.66      400    0.68774    29.73    8.480    0.3    0.9    282.4    5.099    12    0.677.6    0.001803    22.1      411	310	0.55161	23.08	10.542	0.3	0.9	473.4	10.47	24	0.8057	0.001803	172.8
321  0.65268  27.64  9.012  0.3  0.9  350.1  6.949  48  0.7390  0.001803  155.6    330  0.74006  31.73  8.054  0.3  0.9  282.4  5.099  12  0.6778  0.001803  121.6    420  0.78010  33.67  7.713  0.3  0.9  242.7  4.017  24  0.6422  0.001803  25.23    422  0.85455  37.40  7.211  0.3  0.9  228.9  3.647  24  0.6544  0.001803  25.51    421  0.86455  37.40  7.211  0.3  0.9  228.9  3.647  24  0.5544  0.001803  25.51    521  0.95542  42.77  6.719  0.3  0.9  193.2  2.853  12  0.500  0.001803  5.97    433  1.01712  46.29  6.472  0.3  0.9  193.2  2.853  12  0.5009  0.001803  5.97    530   0.9  174.5  2.730  48  0.4400  0.0018	222	0.60426	25.43	9.685	0.3	0.9	402.0	8.396	8	0.7716	0.001803	37.56
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	321	0.65268	27.64	9.012	0.3	0.9	350.1	6.949	48	0.7390	0.001803	155.6
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	400	0.69774	29.73	8.480	0.3	0.9	311.6	5.892	6	0.7078	0.001803	14.06
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	330	0.74006	31.73	8.054	0.3	0.9	282.4	5.099	12	0.6778	0.001803	21.12
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	411								24			42.23
332  0.81817  35.55  7.437  0.3  0.9  242.7  4.017  24  0.6217  0.001803  26.23    422  0.85455  37.40  7.211  0.3  0.9  228.9  3.647  24  0.5954  0.001803  36.10    501  24  277  6.719  0.3  0.9  2972  48  0.5503  0.001803  26.94    440  0.98675  44.53  6.591  0.3  0.9  193.2  2.853  12  0.5009  0.001803  5.97    433  1.01712  46.29  6.472  0.3  0.9  186.7  2.775  24  0.4797  0.01803  9.81    600	420	0.78010	33.67	7.713	0.3	0.9	260.1	4.489	24	0.6492	0.001803	32.80
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	332	0.81817	35.55	7.437	0.3	0.9	242.7	4.017	24	0.6217	0.001803	26.23
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	422	0.85455	37.40	7.211	0.3	0.9	228.9	3.647	24	0.5954	0.001803	21.51
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	431	0.88945	39.21	7.022	0.3	0.9	217.7	3.360	48	0.5702	0.001803	36.10
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	510								24			18.05
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	521	0.95542	42.77	6.719	0.3	0.9	200.3	2.972	48	0.5230	0.001803	26.94
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	440	0.98675	44.53	6.591	0.3	0.9	193.2	2.853	12	0.5009	0.001803	5.97
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	433	1.01712	46.29	6.472	0.3	0.9	186.7	2.775	24	0.4797	0.001803	10.75
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	530								24			10.75
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	442	1.04661	48.06	6.357	0.3	0.9	180.5	2.735	24	0.4594	0.001803	9.81
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	600								6			2.45
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	532	1.07529	49.84	6.244	0.3	0.9	174.5	2.730	48	0.4400	0.001803	18.14
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	611								24			9.07
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	620	1.10322	51.63	6.133	0.3	0.8	168.1	2.759	24	0.4214	0.001803	8.46
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	541	1.13047	53.46	6.022	0.3	0.8	162.4	2.822	48	0.4036	0.001803	16.01
$      \begin{array}{ccccccccccccccccccccccccccccccc$	622	1.15707	55.32	5.913	0.3	0.8	157.0	2.922	24	0.3865	0.001803	7.67
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	631	1.18307	57.22	5.805	0.3	0.8	151.6	3.061	48	0.3702	0.001803	14.87
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	444	1.20852	59.19	5.700	0.3	0.8	146.6	3.245	8	0.3545	0.001803	2.43
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	543	1.23344	61.23	5.598	0.3	0.8	141.7	3.484	48	0.3395	0.001803	14.51
$\begin{array}{ccccccc} 710 & & & & & & & & & & & & & & & & & & &$	550								12			3.63
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	710								24			7.25
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	640	1.25787	63.37	5.503	0.3	0.8	137.3	3.792	24	0.3252	0.001803	7.33
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	552	1.28183	65.64	5.414	0.3	0.8	133.2	4.193	24	0.3114	0.001803	7.53
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	633								24			7.53
	721							. =	48			15.05
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	642	1.30535	68.08	5.332	0.3	0.8	129.4	4.731	48	0.2983	0.001803	15.80
	730	1.32846	70.76	5.258	0.3	0.8	126.1	5.489	24	0.2856	0.001803	8.55
7324824.03( $\gamma$ iron, face-centered cubic, unit-cell dimension $a_o$ = 3.60Å):1110.240569.8418.6870.41.05845.065.5180.95970.000459413512000.2777811.3917.4220.41.05098.048.4360.94670.0004594644.32200.3928416.2114.0040.40.93332.622.88120.89620.0004594376.73110.4606419.1112.3550.30.92575.315.97240.86010.0004594390.02220.4811319.9911.9080.30.92397.514.4480.84840.0004594107.94000.5555623.2610.4720.30.91869.510.2960.80320.000459442.593310.6054025.489.6680.30.91602.78.358240.77090.0004594113.9	651	1.37350	77.46	5.130	0.3	0.8	120.5	8.796	48	0.2620	0.001803	24.03
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	732								48			24.03
1110.240569.8418.6870.41.05845.065.5180.95970.000459413512000.2777811.3917.4220.41.05098.048.4360.94670.0004594644.32200.3928416.2114.0040.40.93332.622.88120.89620.0004594376.73110.4606419.1112.3550.30.92575.315.97240.86010.0004594390.02220.4811319.9911.9080.30.92397.514.4480.84840.0004594107.94000.5555623.2610.4720.30.91869.510.2960.80320.000459442.593310.6054025.489.6680.30.91602.78.358240.77090.0004594113.9	(γ iron, fa	ce-centered cub	ic, unit-cell dim	nension $a_0 = 3.6$	0Å):							
2000.2777811.3917.4220.41.05098.048.4360.94670.0004594644.32200.3928416.2114.0040.40.93332.622.88120.89620.0004594376.73110.4606419.1112.3550.30.92575.315.97240.86010.0004594390.02220.4811319.9911.9080.30.92397.514.4480.84840.0004594107.94000.5555623.2610.4720.30.91869.510.2960.80320.000459442.593310.6054025.489.6680.30.91602.78.358240.77090.0004594113.9	111	0.24056	9.84	18.687	0.4	1.0	5845.0	65.51	8	0.9597	0.0004594	1351
2200.3928416.2114.0040.40.93332.622.88120.89620.0004594376.73110.4606419.1112.3550.30.92575.315.97240.86010.0004594390.02220.4811319.9911.9080.30.92397.514.4480.84840.0004594107.94000.5555623.2610.4720.30.91869.510.2960.80320.000459442.593310.6054025.489.6680.30.91602.78.358240.77090.0004594113.9	200	0.27778	11.39	17.422	0.4	1.0	5098.0	48.43	6	0.9467	0.0004594	644.3
3110.4606419.1112.3550.30.92575.315.97240.86010.0004594390.02220.4811319.9911.9080.30.92397.514.4480.84840.0004594107.94000.5555623.2610.4720.30.91869.510.2960.80320.000459442.593310.6054025.489.6680.30.91602.78.358240.77090.0004594113.9	220	0.39284	16.21	14.004	0.4	0.9	3332.6	22.88	12	0.8962	0.0004594	376.7
222    0.48113    19.99    11.908    0.3    0.9    2397.5    14.44    8    0.8484    0.0004594    107.9      400    0.55556    23.26    10.472    0.3    0.9    1869.5    10.29    6    0.8032    0.0004594    42.59      331    0.60540    25.48    9.668    0.3    0.9    1602.7    8.358    24    0.7709    0.0004594    113.9	311	0.46064	19.11	12.355	0.3	0.9	2575.3	15.97	24	0.8601	0.0004594	390.0
4000.5555623.2610.4720.30.91869.510.2960.80320.000459442.593310.6054025.489.6680.30.91602.78.358240.77090.0004594113.9	222	0.48113	19.99	11.908	0.3	0.9	2397.5	14.44	8	0.8484	0.0004594	107.9
331 0.60540 25.48 9.668 0.3 0.9 1602.7 8.358 24 0.7709 0.0004594 113.9	400	0.55556	23.26	10.472	0.3	0.9	1869.5	10.29	6	0.8032	0.0004594	42.59
	331	0.60540	25.48	9.668	0.3	0.9	1602.7	8.358	24	0.7709	0.0004594	113.9

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					TABLE :	2 Continued	1				
hkl	Sinθ/λ	θ	f	$\Delta f'$	$\Delta f''$	/F/²	LP	Р	T <sup>B</sup>	N <sup>2B</sup>	R <sup>C</sup>
420	0.62113	26.20	9.438	0.3	0.9	1530.2	7.849	24	0.7604	0.0004594	100.7
422	0.68041	28.92	8.674	0.3	0.9	1301.5	6.270	24	0.7199	0.0004594	64.77
333	0.72169	30.86	8.231	0.3	0.9	1177.4	5.423	8	0.6909	0.0004594	16.21
511								24			48.64
440	0.78567	33.94	7.670	0.3	0.9	1029.3	4.414	12	0.6452	0.0004594	16.16
531	0.82168	35.73	7.414	0.3	0.9	965.1	3.978	48	0.6192	0.0004594	52.42
442	0.83333	36.32	7.339			946.6	3.854	24	0.6108	0.0004594	24.57
600								6			6.14
620	0.87841	38.63	7.080	0.3	0.9	884.4	3.444	24	0.5782	0.0004594	19.42
533	0.91076	40.34	6.918	0.3	0.9	846.6	3.214	24	0.5549	0.0004594	16.65
622	0.92128	40.90	6.869	0.3	0.9	835.3	3.149	24	0.5474	0.0004594	15.88
444	0.96225	43.15	6.691	0.3	0.9	794.9	2.943	8	0.5182	0.0004594	4.46
551	0.99187	44.82	6.571	0.3	0.9	768.3	2.837	24	0.4973	0.0004594	11.95
711								24			11.95
640	1.00154	45.38	6.533	0.3	0.9	760.0	2.811	24	0.4906	0.0004594	11.56
642	1.03935	47.62	6.385	0.3	0.9	728.0	2.742	48	0.4644	0.0004594	20.44
553	1.06683	49.30	6.278	0.3	0.9	705.3	2.728	24	0.4457	0.0004594	9.46
731								48			18.91
800	1.11111	52.15	6.101	0.3	0.8	665.8	2.773	6	0.4162	0.0004594	2.12
733	1.13685	53.90	5.997	0.3	0.8	644.7	2.842	24	0.3995	0.0004594	8.07
644	1.14531	54.48	5.962	0.3	0.8	637.6	2.873	24	0.3940	0.0004594	7.96
820								24			7.96
660	1.17851	56.88	5.824	0.3	0.8	610.3	3.033	12	0.3730	0.0004594	3.81
822								24			7.61
555	1.20281	58.74	5.723	0.3	0.8	590.7	3.199	8	0.3580	0.0004594	2.49
751								48			14.92
662	1.21081	59.37	5.691	0.3	0.8	584.5	3.264	24	0.3531	0.0004594	7.43
840	1.24226	61.99	5.564	0.3	0.8	560.4	3.585	24	0.3343	0.0004594	7.41
753	1.26534	64.06	5.475	0.3	0.8	543.8	3.905	48	0.3209	0.0004594	15.03
911								24			7.51
842	1.27294	64.78	5.446	0.3	0.8	538.5	4.030	48	0.3165	0.0004594	15.15
664	1.30289	67.81	5.339	0.3	0.8	519.0	4.666	24	0.2996	0.0004594	8.00
931	1.32492	70.32	5.268	0.3	0.8	506.3	5.352	48	0.2876	0.0004594	17.18
844	1.36083	75.27	5.164	0.3	0.8	487.9	7.391	24	0.2685	0.0004594	10.68
755	1.38193	79.15	5.107	0.3	0.8	478.0	10.26	24	0.2577	0.0004594	13.93
771								24			13.93
933								24			13.93

<sup>*A*</sup> Data from "International Tables for X-Ray Crystallography," *Physical and Chemical Tables*, Vol. III, Kynoch Press, Birmingham, England, 1962, pp 60, 61, 210, 213; Weight  $K_{\alpha 1}$  and  $K_{\alpha 2}$  value used ( $\lambda = 0.71069$ Å).

<sup>B</sup> Temperature factor ( $T = e^{-2M}$ ) where M = B (sin <sup>2</sup>  $\theta$ )/ $\lambda^2$  and 2B = 0.71. Also N is the reciprocal of the unit-cell volume.

<sup>C</sup> Calculated intensity, *R*, includes the variables listed that change with X-ray diffraction peak position.

TABLE 3 Measured Integrated	Intensities and	Values of K
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Peak –	α (200)	γ (200)	γ(220)	α (211)
1	1.00	1.00	1.41	9.50
R	20.73	34.78	47.88	190.8
I:R	0.04824	0.02875	0.02945	0.0497

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